Notice of References Cited Application/Control No. 10/632,563 Examiner Sathyanarayan Pannala Applicant(s)/Patent Under Reexamination CHENG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-2005/0246716 A1	11-2005	Smith et al.	719/315
*	В	US-6,085,198 A	07-2000	Skinner et al.	707/103R
*	С	US-6,591,272 B1	07-2003	Williams, Mark	707/102
*	D	US-6,658,429 B2	12-2003	Dorsett, Jr., David R.	707/1
*	E	US-2001/0054042 A1	12-2001	WATKINS et al.	707/100
*	F	US-2002/0128734 A1	09-2002	Dorsett, David R. JR.	700/73
*	G	US-2002/0184401 A1	12-2002	Kadel et al.	709/315
*	Н	US-2004/0088117 A1	05-2004	Dorsett Jr., David R.	702/022
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	ø					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.